

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/632,948	TOUR ET AL.	
Examiner		Matthew W. Such	Art Unit	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,128,214	10-2000	Kuekes et al.	365/151
*	B	US-6,117,617	09-2000	Kanayama et al.	430/296
*	C	US-5,547,748	08-1996	Ruoff et al.	428/323
*	D	US-6,448,412	09-2002	Murphy et al.	548/417
*	E	US-5,717,076	02-1998	Yamamoto et al.	534/558
	F	US-			
	G	US-			
	H	US-			
	T	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chen, J. et al. SCIENCE. Vol. 286 (19 November 1999): Pages 1550-1552.
	V	Rueckes, T. et al. SCIENCE. Vol. 289 (7 July 2000): Pages 94-97.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.